Search Notes



Application/Control No.

Applicant(s)/Patent Under Reexamination

10652020

AGEYEV ET AL.

Examiner

Art Unit

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2191

SEARCHED

Class	Subclass	Date	Examiner

SEV	RCH	NO.	TEC
JEA	поп	INC	IEO

Search Notes	Date	Examiner
Wei Zhen, SPE (discussed regards to signature)	5/31/2007	SR

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20070531